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Photocouplers GaAlAs Infrared LED & Photo IC

## **TLP5214A**

Isolated IGBT/Power MOSFET gate drive
AC and brushless DC motor drives
Industrial Inverters and Uninterruptible Power Supply (UPS)

The TLP5214A is a highly integrated 4.0 A output current IGBT gate drive photo-coupler housed in a long creepage and clearance SO16L package.

The TLP5214A, a smart gate driver photocoupler, includes functions of IGBT desaturation detection, isolated fault status feedback, soft IGBT turn-off, active Miller cramping and under voltage lockout (UVLO). Moreover, this phorocoupler has features of the desaturation leading edge blanking time, filtering time, and

optimisation of the soft-shutdown performance for secure operation of applications. This photocoupler is suitable for driving IGBT and power MOSFET used in inverter applications.

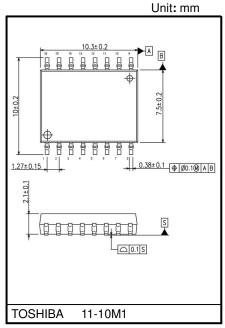
The TLP5214A consists two GaAlAs infrared light-emitting diodes (LEDs) and two high-gain and high-speed ICs. They realize high current, high-speed output control and output fault status feedback.

Peak output current: ±4.0 A (max) Guaranteed performance over temperature: -40 to 110 °C Supply current: 3.8 mA (max) 15 V to 30 V Power supply voltage: Threshold input current: 6 mA (max) Propagation delay time: 150 ns (max) DESAT leading edge blanking time: 1.1 μs (typ.) Common mode transient immunity: ±35 kV/µs (min) 5000 Vrms (min) Isolation voltage:

- UL approved : UL1577, File No.E67349
- c-UL approved :CSA Component Acceptance Service No. 5A, File No.E67349
- Option (D4) VDE: DIN EN60747-5-5 (Note 1)

EN60065 or EN60950-1, EN62368-1

CQC: GB4943.1, GB8898 Japan Factory (Pending)



Weight: 0.37 g (typ.)

Construction mechanical rating

	SO16L
Height	2.3 mm (max)
Creepage Distance	8.0 mm (min)
Clearance	8.0 mm (min)
Insulation Thickness	0.4 mm (min)

Note 1: When a EN60747-5-5 approved type is needed, please designate "Option(D4)"

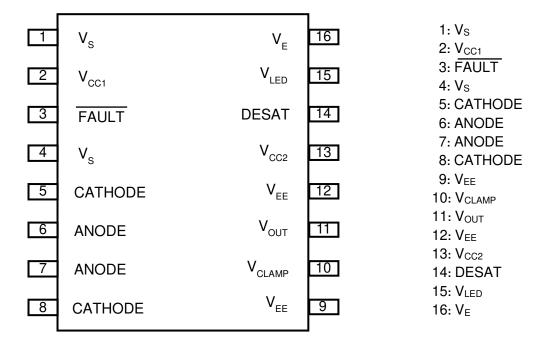
#### **Truth Table**

lF	UVLO	DESAT	FAULT	Vo
IF.	(VCC2-VE)	(14Pin DESAT Terminal Input)	(3Pin FAULT Terminal Output)	Vo
OFF	Not Active ( > VuvLo+)	Not Active	High	Low
ON	Not Active ( > V <sub>UVLO</sub> <sup>+</sup> )	Low ( < VDESATth)	High	High
ON	Not Active ( > VuvLo+)	High ( > VDESATth)	Low ( FAULT)	Low
ON	Active ( < VUVLO <sup>-</sup> )	Not Active	High	Low
OFF	Active ( < VuvLo <sup>-</sup> )	Not Active	High	Low

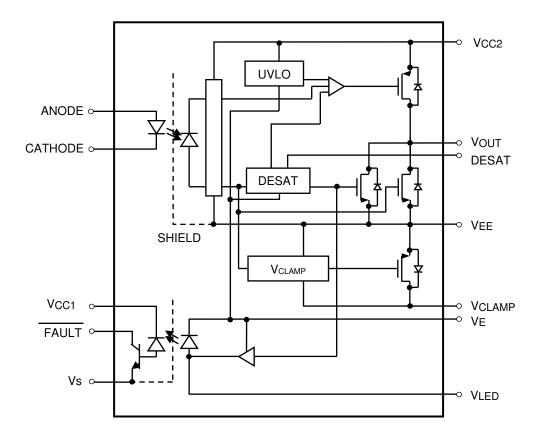
Start of commercial production 2017-03



## **Pin Configuration (top view)**



#### **Internal Circuit**



Note: A  $1-\mu F$  bypass capacitor must be connected between pins 9 and 13, pins 13 and 16.



#### Absolute Maximum Ratings (Note) (Unless otherwise specified, Ta = 25 °C)

	Characteristic	es	Symbol	Rating	Unit
LED	Input forward current	lF	25	mA	
	Input forward current derating (Ta ≥	ΔΙϝ/ΔΤα	-1	mA/°C	
	Peak transient input forward current	(Note 1)	I <sub>FPT</sub>	1	Α
	Peak transient input forward current d	lerating (Ta ≥ 95°C)	ΔΙϝρτ/ΔΤα	-25	mA/°C
	Reverse input voltage		VR	6	V
	Input power dissipation		PD	145	mW
	Input power dissipation derating (Ta	ı ≥ 95°C)	Δ P <sub>D</sub> /ΔTa	-5.0	mW/°C
Detector	Positive input supply voltage		Vcc1	-0.5 to 7	V
	"H" peak output current	Ta = -40 to 110 °C	Іорн	-4.0	Α
	"L" peak output current	(Note 2)	IOPL	+4.0	Α
	FAULT output current		IFAULT	8	mA
	FAULT pin voltage		VFAULT	-0.5 to VCC1	V
	Total output supply voltage		(VCC2-VEE)	-0.5 to 35	V
	Negative output supply voltage		(VE-VEE)	-0.5 to 15	V
	Positive output supply voltage		(VCC2-VE)	-0.5 to 35 - (VE-VEE)	V
	Output voltage		Vo	-0.5 to VCC2	V
	Peak clamping sinking current		lClamp	1.7	Α
	Miller clamping pin voltage		VClamp	-0.5 to VCC2	V
	DESAT voltage		VDESAT	V <sub>E</sub> to V <sub>E</sub> + 10	V
	Output power dissipation		PO	410	mW
	Output power dissipation derating (Ta	Δ ΡΟ /ΔΤα	-14.0	mW/°C	
Common	Operating temperature range	Topr	-40 to 110	°C	
	Storage temperature range	Tstg	-55 to 125	°C	
	Lead soldering temperature (10 s)	(Note 3)	Tsol	260	°C
	Isolation voltage (AC, 60 s, R.H. ≤ 60°	%) (Note 4)	BVS	5000	Vrms

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note: A ceramic capacitor (1  $\mu$ F) should be connected between pins 9 and 13, pins 13 and 16 to stabilize the operation of the high gain linear amplifier. Furthermore, in case V<sub>E</sub> - V<sub>EE</sub> > 0 V, a bypass capacitor, which has good high frequency characteristic, a ceramic capacitor (1  $\mu$ F) should be connected between pins 9 and 16. Failure to provide the bypassing may impair the switching property. The total lead length between capacitor and coupler should not exceed 1 cm.

- Note 1: Pulse width  $P_W \le 1 \mu s$ , 300 pps
- Note 2: Exponential waveform pulse width  $P_W \le 0.2 \mu s$ ,  $f \le 15 \text{ kHz}$ ,  $V_{CC2} = 15 \text{ V}$
- Note 3: For the effective lead soldering area.
- Note 4: This device considered a two-terminal device: All pins on the LED side are shorted together, and all pin on the photodetector side are shorted together.



## **Recommended Operating Conditions (Note)**

Characteristics	Symbol	Min	Тур.	Max	Unit
Total output supply voltage (Note 1)	(VCC2-VEE)	15	-	30	٧
Negative output supply voltage	(VE-VEE)	0	-	15	٧
Positive output supply voltage	(VCC2-VE)	15	-	30 - (V <sub>E</sub> -V <sub>EE</sub> )	٧
Positive input supply voltage	Vcc1	3.3	-	5.5	٧
Input on-state current (Note 2)	IF(ON)	7.5	-	10	mA
Input off-state voltage	V <sub>F(OFF)</sub>	0	-	0.8	٧
Operating frequency (Note 3)	f	-	-	50	kHz

Note: Recommended operating conditions are given as a design guideline to obtain expected performance of the device. Additionally, each item is an independent guideline respectively. In developing designs using this product, please confirm specified characteristics shown in this document.

Note 1: If the  $V_{CC2}$  rise slope is sharp, an internal circuit might not operate with stability. Please design the  $V_{CC2}$  rise slope under 3.0 V /  $\mu$ s.

Note 2: Input signal rise time (fall time)  $\leq 0.5 \mu s$ .

Note 3: Exponential waveform.  $I_{OPH} \ge -4.0 \text{ A} (\le 90 \text{ ns}), I_{OPL} \le 4.0 \text{ A} (\le 90 \text{ ns}), Ta = 110 °C$ 

# Electrical Characteristics (Note) (Unless otherwise specified, Ta = -40 to 110 $^{\circ}$ C, VCC2 - VEE = 15 to 30 V, VE - VEE = 0 V)

Characteristics	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Unit
Input forward voltage	VF	_	IF = 10 mA, Ta = 25°C	1.4	-	1.7	٧
Input reverse current	IR	_	VR = 5 V	-	-	10	μА
Input capacitance	Ct	_	V = 0 V, f = 1 MHz, Ta = 25 °C	-	95	-	pF
FALII T love lovel output voltage	\/ <del>=</del>		IFAULT = 1.1 mA, VCC1 = 5.5 V	-	0.2	0.4	V
FAULT low level output voltage	VFAULTL	_	IFAULT = 1.1 mA, VCC1 = 3.3 V	-	0.2	0.4	]
FALL T high level output ourrent	I=		VFAULT = 5.5 V, VCC1 = 5.5 V, Ta = 25 °C	-	-	0.5	
FAULT high level output current	IFAULTH	_	VFAULT = 5.5 V, VCC1 = 3.3 V, Ta = 25 °C	-	-	0.3	μΑ
Lligh level output ourrent (Nets 1)	lonu	1	VO = VCC2 - 4 V	-	-4.0	-1.2	
High level output current (Note 1)	Іорн	ı	Vo = VCC2 - 7 V	-	-6.5	-3.0	] ,
Lourland output augrent (Nets 1)	loni	2	VO = VEE + 2.5 V	1.2	3.5	-	A
Low level output current (Note 1)	IOPL	VO = VEE + 7 V		3	5.5	-	
Low level output current during fault condition	lolf	_	VO - VEE = 14 V	90	150	230	mA
High level output voltage	Vон	3	IO = -100 mA	VCC2-0.3	VCC2-0.1	-	
Low level output voltage	Vol	4	Io = 100 mA	-	0.1	0.2	v
Clamp pin threshold voltage	V <sub>tClamp</sub>	_	_	-	2.5	-	
Clamp low level sinking current	lcL		VO = VEE + 2.5 V	0.56	1.8	-	Α
High level supply current	ICC2H	5	IO = 0 mA	-	2.4	3.8	
Low level supply current	ICC2L	6	Io = 0 mA	-	2.3	3.8	
Blanking capacitor charging current	Ichg	7	VDESAT = 2 V	-0.33	-0.24	-0.13	mA
Blanking capacitor discharge current	IDSCHG	8	VDESAT = 7 V	10	49	-	
DESAT threshold voltage	VDESAT		VCC2 - VE > VUVLO-	5.9	6.5	7.5	
	Vuvlo+	9	Vo > 5 V	10.5	11.6	13.5	1
UVLO threshold voltage	V <sub>UVLO</sub> -	9	V <sub>O</sub> < 5 V	9.2	10.3	11.1	V
UVLO hysteresis	UVLO <sub>HYS</sub>	_	_	-	1.3	-	
Threshold input current (L/H)	IFLH	10	VCC2 = 30 V, VO < 5 V	-	0.8	6	mA
Threshold input voltage (H/L)	VFHL	_	VCC2 = 30 V, VO > 5 V	0.8	-	-	٧

Note: All typical values are at Ta = 25 °C

Note: This product is more sensitive than conventional products to electrostatic discharge ESD owing to its low power consumption design.

It is therefore all the more necessary to observe general precautions regarding ESD when handling this component.

Note 1:  $I_0$  application time  $\leq 50 \mu s$ , 1 pulse



## Isolation Characteristics (Note) (Ta = 25 °C)

Characteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Capacitance input to output	Cs	Vs = 0 V, f = 1 MHz	-	1.0	-	pF
Isolation resistance	Rs	R.H. ≤ 60 %, V <sub>S</sub> = 500 V	1×10 <sup>12</sup>	10 <sup>14</sup>	-	Ω
		AC, 60 s	5000	-	-	Vrms
Isolation voltage	BVs	AC, 1 s, in oil	-	10000	-	VIIIIS
		DC, 60 s, in oil	-	10000	-	Vdc

Note: This device considered a two-terminal device: All pins on the LED side are shorted together, and all pin on the photodetector side are shorted together.

# Switching Characteristics (Note) (Unless otherwise specified, Ta = -40 to 110 °C, VCC2 - V EE = 15 to 30 V, VE - VEE = 0 V)

Characteristics		Symbol	Test Circuit	Test C	Condition	Min	Тур.	Max	Unit
Propagation delay time	$L\toH$	tpLH			$I_F = 0 \rightarrow 10 \text{ mA}$	50	85	150	
(Note 1)	$H \rightarrow L$	tpHL			IF = 10 → 0 mA	50	90	150	
Output rise time (10-90 %)	(Note 1)	tr		$R_g = 10 \Omega$ ,	I <sub>F</sub> = 0 → 10 mA	-	32	-	
Output fall time (90-10 %)	(Note 1)	tf	11	$C_g = 25 \text{ nF},$	IF = 10 → 0 mA	-	18	-	ns
Pulse with distortion	(Note 1)	tрнL-tрLн		V <sub>CC2</sub> = 30 V	I <sub>F</sub> = 0 ↔ 10 mA	-	-	50	
	(Note 1) (Note 2)	tpsk			I <sub>F</sub> = 0 ↔ 10 mA	-80	-	80	
DESAT sense to 90% dela	ay	tDESAT(90%)			Cg = 25 nF	-	230	500	
DESAT sense to 10% dela	nv	tDESAT(10%)			Cg = 25 nF	1	7.0	8.5	
220/11 001100 10 10 /0 0010	• 9	322711 (1070)		CDESAT = 100 pF,	Cg = 10 nF	-	2.5	3.5	μS
DESAT leading edge blank	king time	tdesat(leb)		Rg = $10 \Omega$ , VCC2 = $30 \text{ V}$ .		1	1.1	-	
DESAT filter time		tdesat(filter)		$R_F = 2.1 \text{ k}\Omega,$		-	90	-	ns
DESAT sense to low level FAULT signal delay		tdesat(fault)	12	12 VCC1 = 5 V		-	350	550	ns
DESAT sense to low propa delay	agation	tdesat(low)			_	-	200	-	113
DESAT input mute		tdesat(mute)				7	20	-	
RESET to high level FAUL signal delay	т	treset(fault)		$\begin{aligned} &\text{CDESAT} = 100 \text{ pF}, \\ &\text{Rg} = 10 \ \Omega, \\ &\text{VCC2} = 30 \text{ V}, \\ &\text{RF} = 2.1 \text{ k}\Omega, \\ &\text{VCC1} = 5.5 \text{ V} \end{aligned}$		0.2	0.6	2	μS
Common-mode transient in at high level output	mmunity (Note 3)	СМн		$T_a = 25 ^{\circ}\text{C},$ $Rg = 10 \Omega,$	V <sub>O (min)</sub> = 26 V, V <sub>FAULT(min)</sub> = 2 V	±35	-	-	
Common-mode transient in at low level output	mmunity (Note 4)	CML	$\begin{array}{l} \text{13 to} \\ \text{16} \\ \text{16} \\ \text{16} \\ \text{RF} = 2.1 \text{ k}\Omega, \\ \text{CF} = 15 \text{ pF}, \\ \text{V}_{\text{CM}} = 1500 \text{ V}_{\text{p-p}} \end{array}$	V <sub>O (max)</sub> = 1 V, V <sub>FAULT(max)</sub> = 0.8 V	±35	-	-	kV/μs	

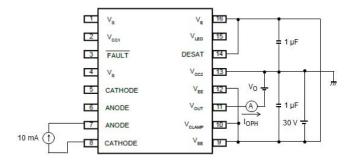
Note: All typical values are at  $T_a = 25$  °C.

Note 1: Input signal (f = 10 kHz, duty = 50%, tr = tf = 5 ns or less)  $C_L$  is approximately 15 pF which includes probe and stray wiring capacitance.

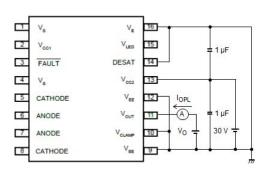
- Note 2: The propagation delay skew, tpsk, is equal to the magnitude of the worst-case difference in tpHL and/or tpLH that will be seen between units at the same given conditions (supply voltage, input current, temperature, etc).
- Note 3:  $CM_H$  is the maximum rate of fall of the common mode voltage that can sustained with the output voltage in the logic high state ( $V_O > 26 \text{ V}$  or  $V_{FAULT} > 2 \text{ V}$ ).
- Note 4:  $CM_L$  is the maximum rate of rise of the common mode voltage that can sustained with the output voltage in the logic low state ( $V_O < 1 \text{ V or V}_{FAULT} < 0.8 \text{ V}$ ).

#### **Test Circuit**

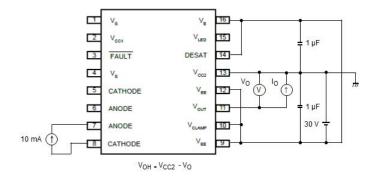
Test Circuit 1: IOPH



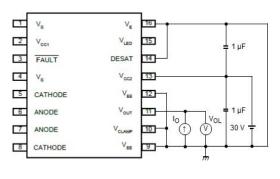
**Test Circuit 2: IOPL** 



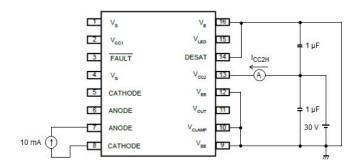
**Test Circuit 3: Voh** 



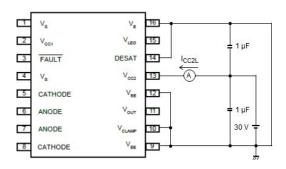
**Test Circuit 4: Vol** 



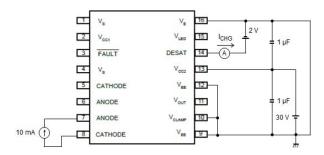
Test Circuit 5: ICC2H



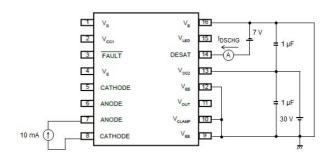
**Test Circuit 6: ICC2L** 



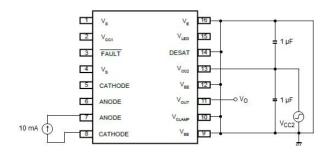
**Test Circuit 7: ICHG** 



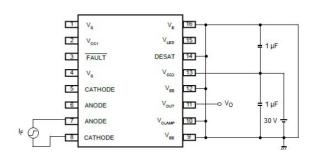
**Test Circuit 8: IDSCHG** 



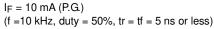
**Test Circuit 9: VUVLO** 

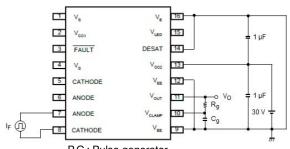


Test Circuit 10: IFLH

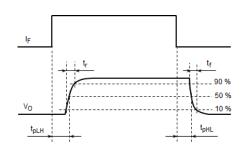


#### Test Circuit 11: tpLH, tpHL, tr, tf, | tpHL-tpLH |



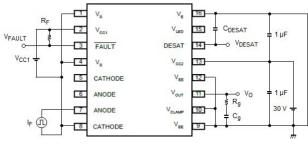


P.G.: Pulse generator

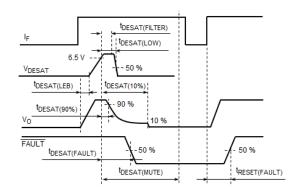


Test Circuit 12: tdesat(90%), tdesat(10%), tdesat(Leb), tdesat(Filter), tdesat(Fault), tdesat(Low), tdesat(Mute), treset(fault)

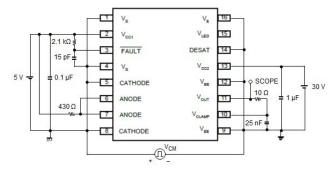
```
I_F = 10 \text{ mA (P.G.)}
(f = 10 \text{ kHz}, \text{ duty} = 50\%, \text{ tr} = \text{tf} = 5 \text{ ns or less})
```



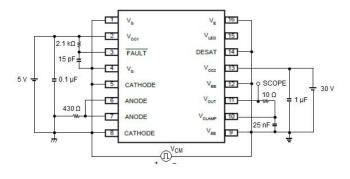
P.G.: Pulse generator



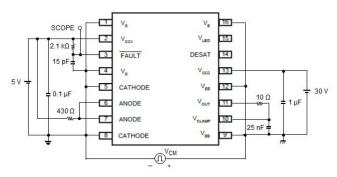
Test Circuit 13: CMR\_LED1 ON



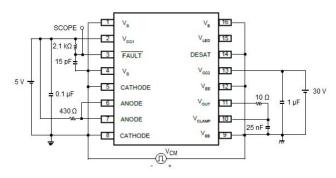
## Test Circuit 14: CMR\_LED1 OFF



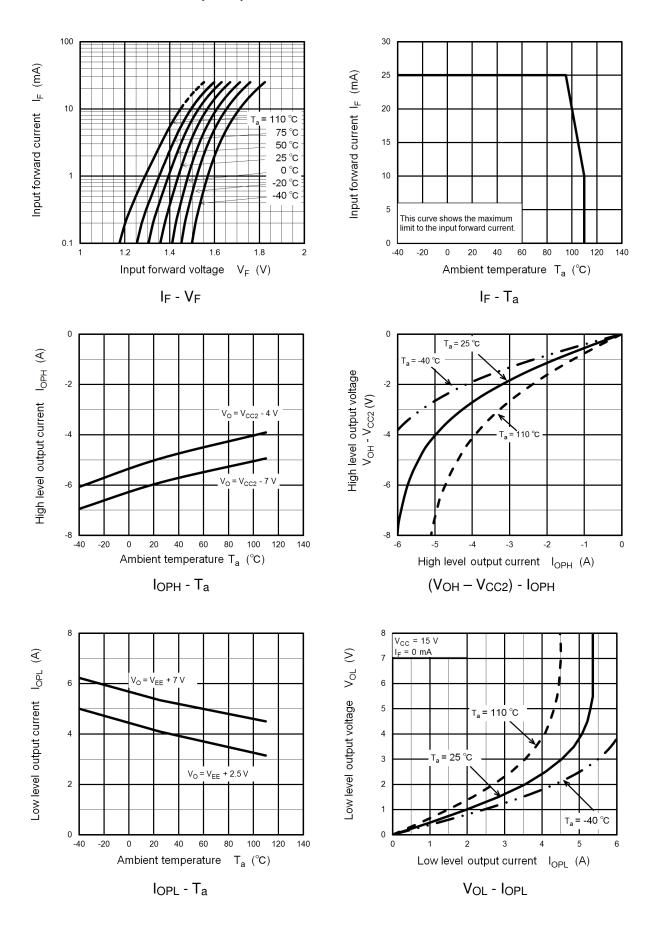
## Test Circuit 15: CMR\_LED2 ON

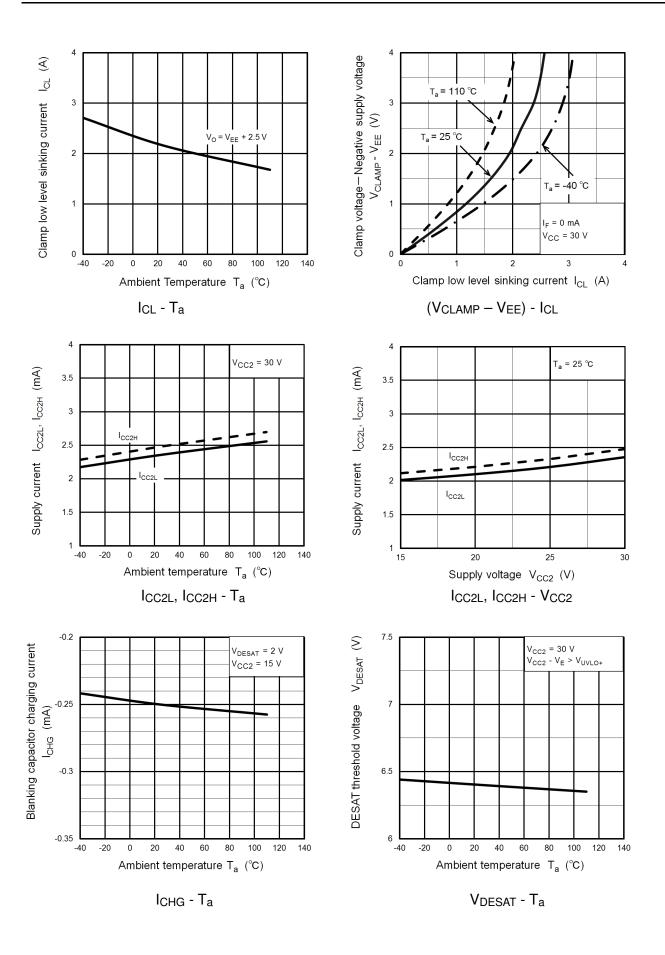


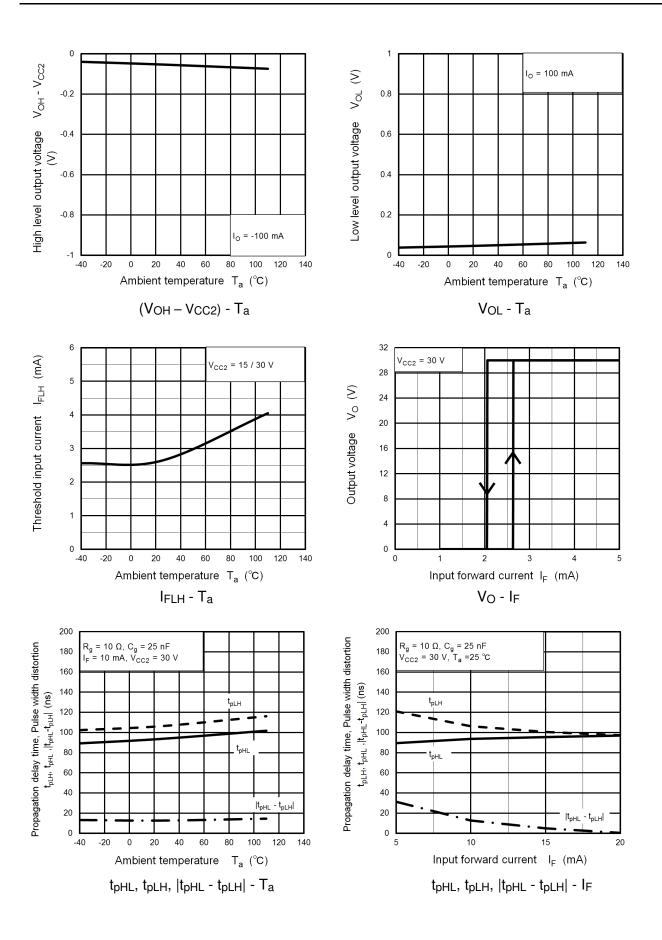
## Test Circuit 16: CMR\_LED2 OFF

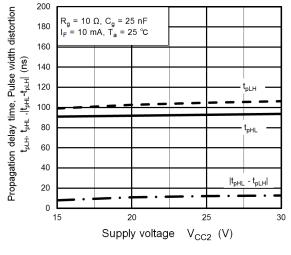


## **Characteristics Curves (Note)**

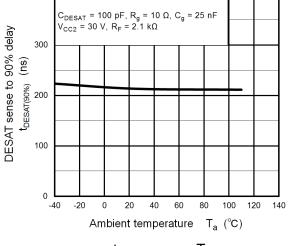






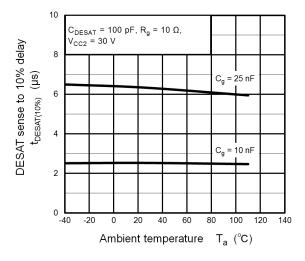


tpHL, tpLH, |tpHL - tpLH| - VCC2

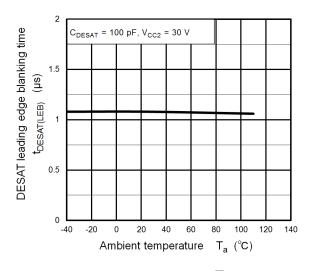


400

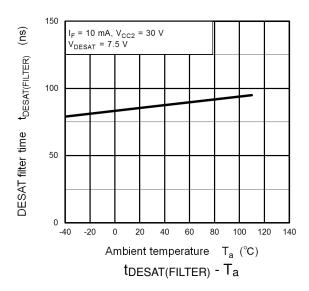
tDESAT(90%) - Ta

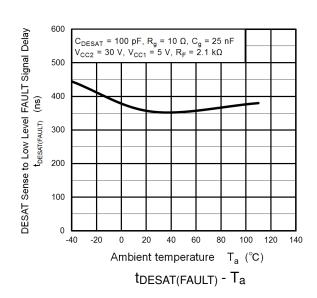


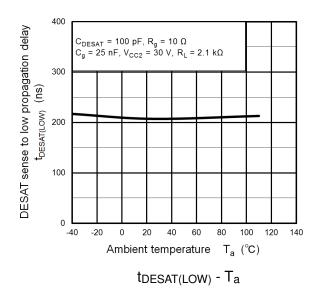
tDESAT(10%) - Ta

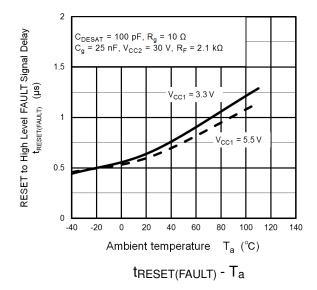


t<sub>DESAT(LEB)</sub> - T<sub>a</sub>









Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

## Soldering and Storage

#### (1) Precautions for Soldering

The soldering temperature should be controlled as closely as possible to the conditions shown below, irrespective of whether a soldering iron or a reflow soldering method is used.

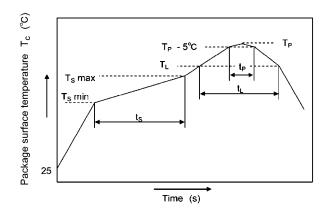
· When using soldering reflow

The soldering temperature profile is based on the package surface temperature.

(See the figure shown below, which is based on the package surface temperature.)

Reflow soldering must be performed once or twice.

The mounting should be complicated with the interval from the first to the last mountings being 2 weeks.



	Symbol	Min	Max	Unit
Preheat temperature	Ts	150	200	°C
Preheat time	ts	60	120	S
Ramp-up rate (T <sub>L</sub> to T <sub>P</sub> )			3	°C/s
Liquidus temperature	T <sub>L</sub>	2	17	°C
Time above T <sub>L</sub>	t∟	60	150	S
Peak temperature	T <sub>P</sub>		260	°C
Time during which $T_c$ is between $(T_P - 5)$ and $T_P$	t <sub>P</sub>		30	s
Ramp-down rate $(T_P \text{ to } T_L)$			6	°C/s

#### An example of a temperature profile when lead(Pb)-free solder is used

· When using soldering flow

Preheat the device at a temperature of 150 °C (package surface temperature) for 60 to 150 seconds. Mounting condition of 260 °C within 10 seconds is recommended.

Flow soldering must be performed once.

· When using soldering iron

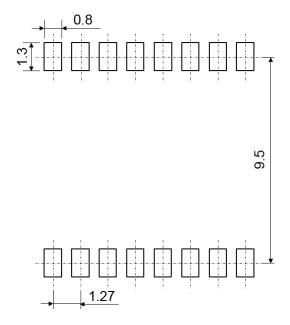
Complete soldering within 10 seconds for lead temperature not exceeding 260 °C or within 3 seconds not exceeding 350 °C.

Heating by soldering iron must be done only once per lead.

#### (2) Precautions for General Storage

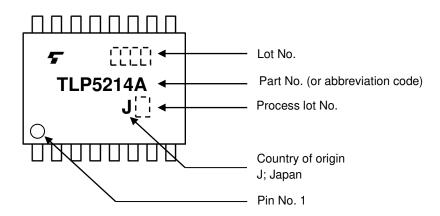
- · Avoid storage locations where devices may be exposed to moisture or direct sunlight.
- Follow the precautions printed on the packing label of the device for transportation and storage.
- Keep the storage location temperature and humidity within a range of 5 °C to 35 °C and 45 % to 75 %.
- Do not store the products in locations with poisonous gases (especially corrosive gases) or in dusty conditions.
- Store the products in locations with minimal temperature fluctuations. Rapid temperature changes during storage can cause condensation, resulting in lead oxidation of corrosion, which will deteriorate the solderability of the leads.
- · When restoring devices after removal from their packing, use anti-static containers.
- Do not allow loads to be applied directly to devices while they are in storage.
- If devices have been stored for more than two years under normal storage conditions, it is recommended that you check the leads for ease of soldering prior to use.

## **Land Pattern Dimensions for Reference Only**



Unit: mm

## Marking





## **Embossed-Tape Packing (TP) Specification for Mini-Flat Photocouplers**

#### 1. Applicable Package

Package	Product Type
SO16L	Long creepage mini flat coupler

#### 2. Product Naming Conventions

Type of package used for shipment is denoted by a symbol suffix after a part number. The method of classification is as below.

Example) TLP5214A(TP,E(O

Part number: TLP5214A

Tape type: TP

[[G]]/RoHS COMPATIBLE: E (Note 1)

Domestic ID (Country / Region of origin: Japan): (O

Note 1 : Please contact your Toshiba sales representative for details on environmental information such as the product's RoHS compatibility.

RoHS is the Directive 2011/65/EU of the European Parliament and of the Council of 8 June 2011 on the restriction of the use of certain hazardous substances in electrical and electronic equipment.

#### 3. Tape Dimensions Specification

Таре Туре	Division	Packing Amount (A unit per reel)
TP	_	1500

#### 3.1 Orientation of Device in Relation to Direction of Feed

Device orientation in the carrier cavities as shown in Figure 1.

Tape feed Tape f

Figure 1 Device Orientation

#### 3.2 Empty Cavities

Characteristics	Criterion	Remarks
Occurrences of 2 or more successive empty cavities	0 device	Within any given 40-mm section of tape, not including leader and trailer
Single empty cavity	6 devices (max) per reel	Not including leader and trailer

## **TLP5214A**

#### 3.3 Tape Leader and Trailer

The start of the tape has 14 or more empty holes. The end of the tape has 34 or more empty holes and more than 30 mm only for a cover tape.

#### 3.4 Tape Dimensions

Tape material: Plastic (for protection against static electricity)

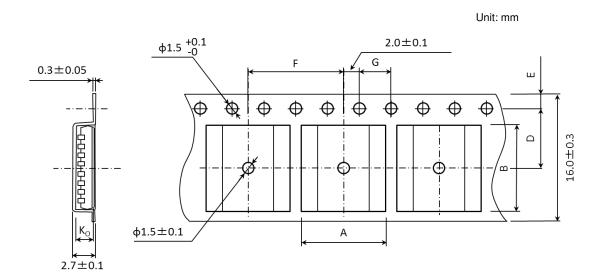


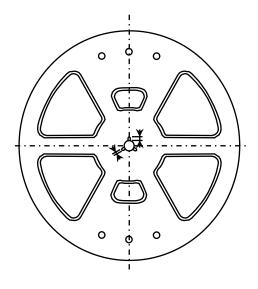
Table Tape Dimensions (unit: mm, tolerance: ±0.1)

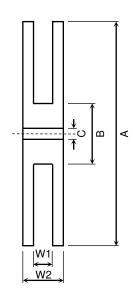
Symbol	Dimension	Remark
А	10.4	_
В	10.7	_
D	7.5	Center line of embossed cavity and sprocket hole
E	1.75	Distance between tape edge and sprocket hole center
F	12.0	Cumulative error +0.1/-0.3 (max) per 10 empty cavities holes
G	4.0	Cumulative error +0.1/-0.3 (max) per 10 sprocket holes
К <sub>0</sub>	2.4	Internal space



#### 3.5 Reel Specification

Material: Plastic



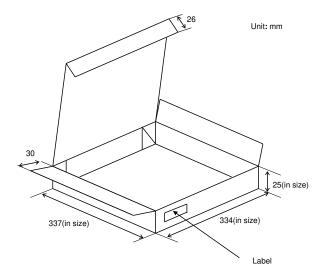


**Table Reel Dimensions** 

Unit: mm

Symbol	Dimension
Α	Ф330 ± 2
В	Ф100 ± 1
С	Ф13 ± 0.5
Е	$2.0 \pm 0.5$
U	4.0 ± 0.5
W1	17.4 ± 1.0
W2	21.4 ± 1.0

## 4. Packing (Note)



Note: Taping reel diameter: Φ330 mm

#### 5. Label Format

- (1) Carton: The label provides the part number, quantity, lot number, the Toshiba logo, etc.
- (2) Reel: The label provides the part number, the taping name, quantity, lot number, etc.



#### 6. Ordering Method

When placing an order, please specify the part number, the tape and the quantity (Multiples of 1500) as shown in the following example.

Example) TLP5214A(TP,E(O 1500 pcs

Part number: TLP5214A Tape type: TP (12-mm pitch)

[[G]]/RoHS COMPATIBLE: E (Note 1)

Domestic ID (Country/Region of origin: Japan): O Quantity (must be a multiple of 1500): 1500 pcs

Note 1 :Please contact your Toshiba sales representative for details on environmental information such as the product's RoHS compatibility.

RoHS is the Directive 2011/65/EU of the European Parliament and of the Council of 8 June 2011 on the restriction of the use of certain hazardous substances in electrical and electronic equipment.



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